Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/678,990	BOBROWSKI, PAUL J.
Examiner	**Art Unit**
Patricia Leith	1655

SEARCHED			
Class	Subclass	Date	Examiner
none			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN: Indexed Bioscience (76 database cluster)	7/27/2005	PL
EAST: JPO, EPO, DERWENT, USPATFUL, USPGPUBS, USOCR	7/27/2005	PL
Inventor name search PALM/EAST	8/4/05	PL